

<b>Notice of References Cited</b>	Application/Control No. 10/773,610	Applicant(s)/Patent Under Reexamination YAMANAKA ET AL.	
	Examiner Emmanuel Bayard	Art Unit 2611	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,187,730	03-2007	Hu et al.	375/343
*	C	US-6,088,390	07-2000	Russell et al.	375/233
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**NON-PATENT DOCUMENTS**

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